

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination TOKUDA ET AL.	
		Examiner John P. Leubecker	Art Unit 3739	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,889,662	06-1975	Mitsui, Kazuhiko	600/139
*	B	US-6,147,808	11-2000	Togino, Takayoshi	359/637
*	C	US-5,140,975	08-1992	Krauter, Allan I.	600/139
*	D	US-5,305,759	04-1994	Kaneko et al.	600/476
*	E	US-6,930,705	08-2005	Tanaka, Chinari	348/45
*	F	US-6,530,882	03-2003	Farkas et al.	600/168
*	G	US-2004/0122289	06-2004	Mizuno, Rogerio Jun	600/168
*	H	US-2005/0228229	10-2005	Harris, Martin Russell	600/168
*	I	US-2003/0233028	12-2003	Tokuda et al.	600/160
*	J	US-5,742,419	04-1998	Dickensheets et al.	359/201
*	K	US-2006/0061892	03-2006	Penn, Steven M.	359/833
*	L	US-2002/0018276	02-2002	Suga, Takeshi	359/212
*	M	US-6,809,866	10-2004	Xie et al.	359/618

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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